

**Search Notes**

Application/Control No.

10/722,589

Examiner

Mark W. Bockelman

Applicant(s)/Patent under  
Reexamination

COHEN ET AL.

Art Unit

3766

**SEARCHED**

Class	Subclass	Date	Examiner
607	63,40, 45-46, 62, 148-149	2-17-06	MS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR